# Electron Microscopes and Cameras

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### Transmission Cryo-Electron Microscopy A tool used by structural biologists to study molecular nanomachines

Gabriel Lander, Thesis Defense 2009



(http://www.eicn.ucla.edu/xiaorui)

### Outline

- I. Electron Microscope & Optics
- II. Cameras from CCD to DED
- III. Advanced Software Control

# I. Electron Microscope & Optics



• First EM was built by Ernst Ruska and Max Knoll in 1931















Fabian de Kok-Mercado, Victoria Wahl-Jensen, and Laura Bollinger NIAID IRF Science 335, (2012) 6068

#### Anatomy of a TEM



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- 1. Electron Gun beam source
- 2. Illumination System Condenser lenses
- 3. Imaging System Objective lenses
- 4. Projection system Projector lenses
- 5. Recording system detectors

#### **Hardware Components**

- 1. Electromagnetic lenses (condenser, objective, projectors)
- 2. Alignment coils, stigmator coils, blanker & shutter coils
- 3. Apertures
- 4. Cameras



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### **Magnetic Lens**



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#### **Beam Source**



https://www.thermofisher.com/blog/microscopy/electron-source-fundamentals/

#### **Beam Source**



S .Henning et al, "Microscopy Methods in Nanomaterials Characterization", 2017

#### **FEG Beam Source Types**

Schottky-type

Cold-FEG

- 1. High temperature  $\sim$  1800 K
- 2. Energy spread ~ 0.7eV
- 3. Stable beam Intensity

- 1. Room temperature
- 2. Energy spread ~ 0.3eV
- 3. Decrease with time

#### **Coherence of a Beam Source**

**Spatial Coherence** -- electrons emitting from small area

**Temporal Coherence --** narrow wavelength range



#### The Basic Electron Condenser System

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# Aberrations due to Imperfect Lens

- Defocus
- Astigmatism
- Coma
- Spherical aberration
- CTF
- •

They are corrected with additional lenses / coils In the microscope

OR

In **software** after the image is collected ("CTF correction")

#### Focus terminology

#### underfocus

overfocus





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# **Astigmatism (example)**



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### **Condenser Beam Astigmatism Correction**



# **Astigmatism Correction**

Correcting the astigmatism on the objective lens

Routine alignment using Fresnel fringe

More accurate with FFT

Remember to correct the condenser lens too

underfocus overfocus 50 nm

exact focus

astigmatism







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MRC-LMB CryoEM Course 2017

### Coma – tilted beam



Example image from I. Norman

# **Illumination Conditions**



**Overfocused beam** 

#### **Axial Coma**

**Off-axis Coma** 

R Glaeser et al, Journal of Structural Biology 174(1):1-10

### Beam Tilt Introduces:

$$\Delta z_{
m effective} - \Delta z_{
m no \ beam \ tilt} = -2 C_{
m s} heta^2$$

**Excess of increment of defocus** 

$$A_{\text{beam tilt}} = C_s \theta^2$$
,

**Excess astigmatism** 

Phase error =  $2\pi\theta C_{\rm s}\lambda^2 s^3(\hat{\boldsymbol{\theta}}\cdot\hat{\boldsymbol{s}})$ 

**Coma -> Phase Error** 

R Glaeser et al, Journal of Structural Biology 174(1):1-10

### Coma Free – by minimizing beam tilt



- **1. Voltage Centering**
- 2. Current Centering
- 3. Zemlin Tableaux

R Glaeser et al, Journal of Structural Biology 174(1):1-10

# Parallel Beam – a verifying procedure

$$\Delta z_{
m effective} - \Delta z_{
m no \ beam \ tilt} = -2C_{
m s}\theta^2$$

 $A_{\text{beam tilt}} = C_s \theta^2$ ,

With a large beam tilt ~ 10 mrad

- Take an image
- Perform FFT of sub-areas
- Compare defocus and astigmatism of them
- Adjust Intensity (C2) & repeat above

### Parallel Beam – a practical procedure



#### Parallel illumination on a Talos Arctica

- Eucentric focus
- Insert Obj Aperture in Diffr. mode
- Adjust Focus Knob until aperture edge is sharp
- Adjust Intensity (C2) until diff. rings are sharp

M Herzik et al, Nature Methods 14, pages 1075–1078 (2017)

# Parallel Beam – An Alternative Procedure

#### **Questions / Concerns:**

- 1. Obj Aperture might not sit at Back Focal Plane
- 2. Hard to find precise intermediate lens value for sharp aperture edge

#### An Alternative Method

- 1. Z at Eucentricity Height
- 2. Measure pixelsizes with different C2 values
- 3. Z + 100 um
- 4. Measure pixelsize with different C2 values
- 5. Find interception of two lines plotted.

\* On Krios with C3, the term is ImageDistanceOffset

Wim Hagen, private communication

Beam-Image Shift





Beam-Image Shift



- 1. Is a single action of microscope
- 2. Used in Low Dose Conditions
- 3. Used in high-throughput exposures
- 4. Induces aberrations due to
  - Axial coma
  - Astigmatism

# **Spherical Aberration**

Lens is stronger off axis

Plane of least confusion



# Spherical Aberration & Cs Corrector





Cs = 0.5 – 3.0mm

# CTF

Phil. Trans. Roy. Soc. Lond. B. 261, 105–118 (1971) [ 105 ] Printed in Great Britain

> 0Å +100

Measurement and compensation of defocusing and aberrations by Fourier processing of electron micrographs

> BY H. P. ERICKSON AND A. KLUG, F.R.S. Medical Research Council Laboratory of Molecular Biology, Cambridge

Contrast Transfer Function



 $= 100^{1}$   $= 100^{1}$ 

Can be corrected by software as post-process

### **Large Number of Signals**



### **Objective Aperture**





# Objective aperture



# II. Cameras – from CCD to DED





#### Gatan Orius CCD & TVIPS TemCam 224HD CCD cameras on CM120



#### What is a CCD?

*Charge Coupled Devices* (CCDs) were invented in the 1970s and originally found application as memory devices. Their light sensitive properties were quickly exploited for imaging applications and they produced a major revolution in Astronomy. They improved the light gathering power of telescopes by almost two orders of magnitude. Nowadays an amateur astronomer with a CCD camera and a 15 cm telescope can collect as much light as an astronomer of the 1960s equipped with a photographic plate and a 1m telescope.

CCDs work by converting light into a pattern of electronic charge in a silicon chip. This pattern of charge is converted into a video waveform, digitized and stored as an image file on a computer.



**Willard S. Boyle and George E. Smith** Bell Laboratories, Murray Hill, NJ, USA

2009 Nobel Prize in Physics

"for the invention of an imaging semiconductor circuit – the CCD sensor"

#### Photoelectric Effect

The effect is fundamental to the operation of a CCD. Atoms in a silicon crystal have electrons arranged in discrete energy bands. The lower energy band is called the Valence Band, the upper band is the Conduction Band. Most of the electrons occupy the Valence band but can be excited into the conduction band by heating or by the absorption of a photon. The energy required for this transition is 1.26 electron volts. Once in this conduction band the electron is free to move about in the lattice of the silicon crystal. It leaves behind a 'hole' in the valence band which acts like a positively charged carrier. In the absence of an external electric field the hole and electron will quickly re-combine and be lost. In a CCD an electric field is introduced to sweep these charge carriers apart and prevent recombination.



Thermally generated electrons are indistinguishable from photo-generated electrons. They constitute a noise source known as 'Dark Current' and it is important that CCDs are kept cold to reduce their number.

1.26eV corresponds to the energy of light with a wavelength of 1µm. Beyond this wavelength silicon becomes transparent and CCDs constructed from silicon become insensitive.





#### Complementary Metal Oxide Semiconductor Device

Camera Circuit Board





CCDs move photogenerated charge from pixel to pixel and convert it to voltage at an output node. CMOS imagers convert charge to voltage inside each pixel.

https://meroli.web.cern.ch/lecture\_cmos\_vs\_ccd\_pixel\_sensor.html

#### **Spectral Reponses for CCD and CMOS Sensors**



http://www.astrosurf.com/luxorion/Physique/spectral-response-ccd.jpg

F. Pardo, IEEE Journal of Solid-State Circuits 33(6):842 - 849

For TEM, the electrons need to be converted to photon signal so that the developed technology of CCD can be used. **Two Key Questions for a Camera** 

- 1. How is the voltage signal generated, from electron or photon?
- 2. How is the voltage signal read out?

#### Electron to Photon Conversion in Scintillator layer Results in Information Loss



**CCD:** multi stage conversion of electron energy via fiber or lens optics



For cryoEM sample, with conventional camera with scintillator, it is difficult to get resolution better than 1nm!

#### Direct Electron Detector (DED)

DED with CMOS "Monolithic Active Pixel Sensors"

- Primary electron generates 100-300 electrons in P<sup>-</sup> Epilayer
- Electrons collect in closest well and have to be read out frequently
- Backscatter still a big problem unless substrate is severely thinned (from 700  $\mu m$  to 30-50  $\mu m)$



**Fig. 1.** Schematic of MAPS detector shown in cross-section. The detector has three main regions: (a) about 5- $\mu$ m-thick passivation layer plus interconnections for readout electronics in the P well, (b) a few microns of lightly doped epilayer where the useful signal is generated, and drifts on to N wells prior to being read out, and (c) the main bulk of the detector, the substrate, which is heavily doped and which does not play a significant role in the detection process. A possible path for a single incident high-energy electron is shown to illustrate the problem with backscatter from the substrate.

#### CCD vs. DED









#### Integration vs Counting



Detection Quantum Efficiency (DQE)



- DQE =SNR<sup>2</sup>o/SNR<sup>2</sup>i ٠
- A measure of the signal to ٠ noise ratio degradation
- Perfect detector has DQE of 1



**Greg McMullan** 

Christos Savva 2017 MRC Course

#### Super-resolution





Counting

Counting with Super-Res

On the Market – for high-end DED

- Direct Electron
  - DE-12 (4k x 3k) DE-20 (5k x 4k) Apollo (4k x 4k)
- **TFS** Falcon 2, 3, 4 (4i)
- Gatan
  - K2/3 Summit
- Others.....

### Apollo



#### World's First Event-Based Active Pixel Direct Detector

- Our novel direct detection device (DDD<sup>®</sup>) delivers ultra-low noise and extraordinary resolution for almost any beam brightness.
- Electron counting in hardware through a combination of sensor technology & FPGA edge computing.
- Speed equivalent to a large-pixel direct detector counting at 2,400 fps.
- **On-chip CDS** minimizes noise and maximizes detection efficiency.
- 4k × 4k (16.8 million) physical pixels with larger 8 μm pixel size to maximize resolution (MTF).
- hysical pixels size to 1TF). 8k (67.1 MP) readout

Direct Ele

- Super-resolution 8k × 8k (67.1 MP) readout to the computer at 60 fps for motion correction, dose filtering, etc.
- Elegant, powerful, and easy-to-use for cryo-EM.
- Integrated with SerialEM for **automated** data acquisition.



### Hybrid-Pixel Camera – a different type of DED



- Ionizing radiation type of detector (semiconductor sensor + ASIC readout chip)
- Solder bump to couple them together (hybrid)

# Hybrid-Pixel Camera – a different type of DED

- Direct (electron) detector with good DQE
- Noiseless
- Very high readout frame rate (4500Hz, 8bit)
- 30-200 keV
- ~ 512 x 512 1000 x 1000 pixels
- Pixel size 75 um
- Commonly used in X-ray and synchrotron beam line
- Very good for diffraction data



Singla, Quadro, ELA





Stela – 4D STEM

CheeTa - Diffraction

# III. Advanced Software Control

#### From Analog to Digital









# The Task of a TEM Operator

- With the best beam conditions, then
- Go to a spot x,y,z, $\alpha$ ,( $\beta$ )
- Focus
- Record
- (repeat)



# THANK YOU